

MXD8545A

0.1-3.0GHz SP4T Antenna Tuning Switch





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General Description

The MXD8545A is a CMOS silicon-on-insulator (SOI), single-pole, four-throw (SP4T) switch. The high linearity and ruggedness performance and extremely low insertion loss makes the device an ideal choice for GSM/WCDMA/LTE handset antenna tuning application.

The MXD8545A SP4T switch is provided in a compact QFN 1.1mm x 1.5mm x 0.38mm package. A functional block diagram is shown in Figure 1. The pin configuration and package are shown in Figure 2. Signal pin assignments and functional pin descriptions are provided in Table 1.

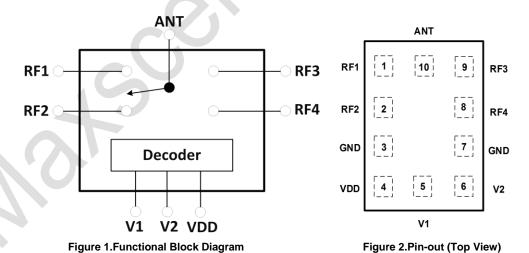
Applications

- GSM/WCDMA/LTE band and mode switching
- Antenna tuning switch

Features

- Broadband frequency range: 0.1 to 3.0 GHz
- Low insertion 0.50dB @ 2.7 GHz
- High P0.1dB of 43.3dBm
- Positive low voltage control: VC = 1.0 to 3.0 V,
 VDD = 2.5 to 3.3 V, Small QFN (10-pin,
 1.1mm x 1.5mm x 0.38mm) package , MSL1

Functional Block Diagram and Pin Function





Application Circuit

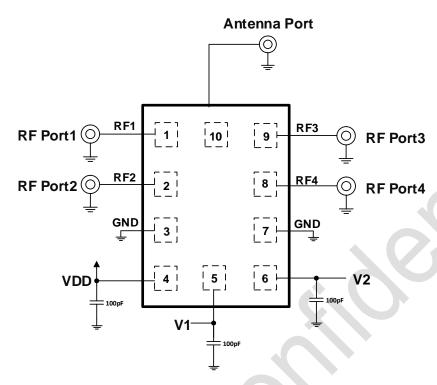


Figure 3. MXD8545A Application Circuit

Table 1. Pin Description

Table 1. Pir	n Descriptio	n			
Pin No.	Name	Description	Pin No.	Name	Description
1	RF1	RF port 1	6	V2	Control Logic #2
2	RF2	RF port 2	7	GND	Ground
3	GND	Ground	8	RF4	RF port 4
4	VDD	DC power supply	9	RF3	RF port 3
5	V1	Control Logic #1	10	ANT	Antenna port

Truth Table

Table 2.

State	V1	V2	RF Path
RF1	0	0	ANT to RF1
RF2	0	1	ANT to RF2
RF3	1	0	ANT to RF3
RF4	1	1	ANT to RF4

Note: "1" = 1.0 V to 3.00 V. "0" = 0 V to +0.3 V.

Recommended Operation Range

Table 3.

Parameters	Symbol	Min	Тур	Max	Units
Operation Frequency	f1	0.1	ı	3.0	GHz
Power supply	V_{DD}	2.5	2.8	3.3	V
Switch Control Voltage High	V_{CTL_LH}	1.0	1.8	3.0	V
Switch Control Voltage Low	V_{CTL_L}	0	0	0.3	V



Specifications

Table 4.Electrical Specifications

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Parameter	Symbol	Min.	Typical	Max.	Units	Test Condition	
DC Specifications	•						
Control voltage:	.,	_			.,		
Low High	V _{CTL_L} V _{CTL_H}	0 1.0	0 1.8	0.3 3.0	V		
Supply voltage	VCIL_H V _{DD}	2.5	2.8	3.3	V		
Supply current	I _{DD}		75	110	uA	V _{DD} = 2.8 V	
Control current	I _{CTL}		1	5	uA	V _{CTL} = 1.8 V	
RF Specifications	•				•		
Insertion loss	IL		0.35 0.45 0.50	0.45 0.55 0.70	dB dB dB	0.8 to 1.0 GHz 1.0 to 2.2 GHz 2.2 to 3.0 GHz	
Isolation	ISO	26 22 19	28 24 22		dB dB dB	0.8 to 1.0 GHz 1.0 to 2.2 GHz 2.2 to 3.0 GHz	
Return loss	S ₁₁		20		dB	0.8 to 3.0 GHz	
Voltage Standing Wave Ratio	VSWR		1.20			0.8 to 3.0 GHz	
On Resistance (RF1/2/3/4 to ANT)	Ron		1.05	1.15	Ω	Switch on Path	
OFF Capacitance (RF1/2/3/4 to ANT)	Coff		130	150	fF	Switch off Path	
Input 0.1 dB compression point	P _{0.1dB}	+43	+43.3		dBm	0.8 to 3.0 GHz, ANT to RF1/2/3/4	
Peak RF operating voltage	V_{peak}		45		V	f0 = 700 to 2700 MHz, CW 25% duty cycle	
RF Voltage @3f0=-40dBm	V_{peak}		35		V	f0 = 700 to 2700 MHz, CW 25% duty cycle	
LTE TX harmonic	2f0		-90	-80	dBm	f0 = 700 to 2700 MHz, PIN = +26	
(RF1/2/3/4 to ANT)	3f0		-80	-70	dBm	dBm	
GSM LB harmonic	2f0		-60	-50	dBm	f0 = 824 to 915 MHz, PIN = +35	
(RF1/2/3/4 to ANT)	3f0		-60	-50	dBm	dBm	
GSM HB harmonic	2f0		-60	-50	dBm	f0 = 1710 to 2690 MHz, PIN = +33	
(RF1/2/3/4 to ANT)	3f0		-60	-50	dBm	dBm	
Second order intermodulation	IMD2		-112	-105	dBm	CW Carrier on RF Port, +20 dBm CW Interferer on ANT port, -15 dBm	
Third order intermodulation	IMD3		-112	-105	dBm	CW Carrier on RF Port, +20 dBm CW Interferer on ANT port, -15 dBm	
Switching on time			3.0	5.0	μs	50% VCTL to 90% RF	
Switching off time			3.0	5.0	μs	50% VCTL to 10% RF	
Startup time			10	20	μs	Power off state to any RF switch state	



Table 5. IMD2 Test Conditions

Band	In-band freq	CW C	arrier	CW Interferer		
Danu	MHz	MHz	dBm	MHz	dBm	
1 Low	2140	1950	+20	190	-15	
1 High	2140	1950	+20	4090	-15	
5 Low	881.5	836.5	+20	45	-15	
5 High	881.5	836.5	+20	1718	-15	

Table 6. IMD3 Test Conditions

Band	In-band freq	CW C	arrier	CW Interferer	
Ballu	MHz	MHz	dBm	MHz	dBm
1	2140	1950	+20	1760	-15
5	881.5	836.5	+20	791.5	-15

Absolute Maximum Ratings

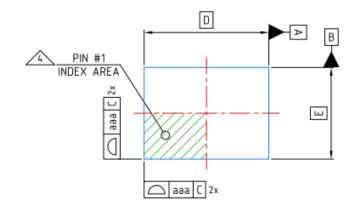
Table 7. Maximum ratings

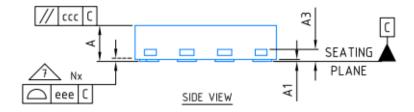
Parameters	Symbol	Minimum	Maximum	Units
Supply voltage	V_{DD}	+2.5	+3.6	V
Digital control voltage	V_{CTL}	0	+3.6	V
input power (RF port, 25% DC)	P _{IN}		+43.8	dBm
input power (RF port, VSWR =10:1, CW)	P _{IN}		+38	dBm
input power (RF port, LTE 10M Full RB, VSWR =10:1,CW)	P _{IN}		+32	dBm
input power (GSM LB, CW and 50% DC)	P _{IN}		+40	dBm
input power (GSM HB, CW and 50% DC)	P _{IN}	>	+38	dBm
Operating temperature	T _{OP}	-35	+90	°C
Storage temperature	T _{STG}	- 55	+150	°C
Electrostatic Discharge Human body model (HBM), Class 2	ESD_HBM		1500	
Machine Model (MM), Class B	ESD_MM		150	V
Charged device model (CDM), Class III	ESD_CDM		500	

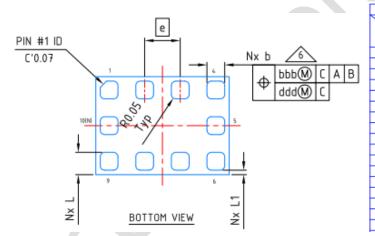
Note: Exposure to maximum rating conditions for extended periods may reduce device reliability. There is no damage to device with only one parameter set at the limit and all other parameters set at or below their nominal value. Exceeding any of the limits listed here may result in permanent damage to the device.



Package Outline Dimension







	Dimension Table						
Symbol A		X2					
Mb01	MINIMUM	NOMINAL	MAXIMUM				
A	0.31	0.38	0.40				
A1	0.00	0.02	0.05				
A3		0.12 Ref.					
ь	0.15	0.20	0.25				
D	1.50 BSC						
Е	1.10 BSC						
е		0.40 BSC					
L	0.15	0.25	0.35				
L1		0.05					
aaa		0.05					
bbb		0.07					
ccc	0.10						
ddd		0.05					
eee		0.08					
N		10					
ND	4						
NE		1					

Figure 4. Package outline dimension



Marking Specification

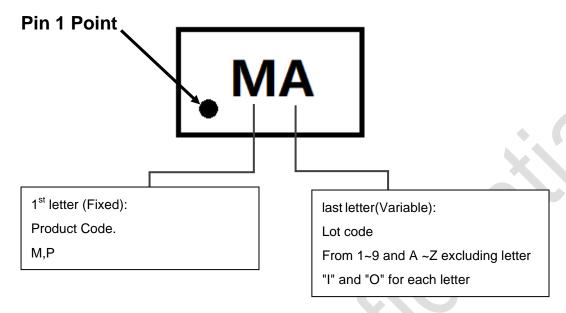


Figure 5. Marking specification (Top View)



Reflow Chart

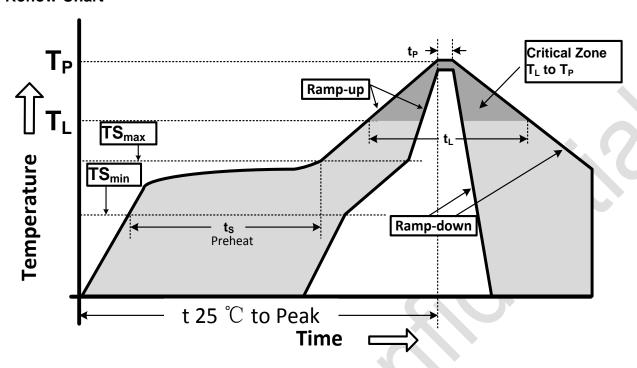


Figure 6. Recommended Lead-Free Reflow Profile

Table 8.

Profile Parameter	Lead-Free Assembly, Convection, IR/Convection
Ramp-up rate (TS _{max} to T _p)	3°C/second max.
Preheat temperature (TS _{min} to TS _{max})	150℃ to 200℃
Preheat time (t _s)	60 - 180 seconds
Time above TL , 217℃ (t _L)	60 - 150 seconds
Peak temperature (T _p)	260℃
Time within 5℃ of peak temperature(t _p)	20 - 40 seconds
Ramp-down rate	6°C/second max.
Time 25°C to peak temperature	8 minutes max.

ESD Sensitivity

Integrated circuits are ESD sensitive and can be damaged by static electric charge. Proper ESD protection techniques should be used when handling these devices.

RoHS Compliant

This product does not contain lead, mercury, cadmium, hexavalent chromium, polybrominated biphenyls (PBB) and polybrominated diphenyl ethers (PBDE), and are considered RoHS compliant.